

Six-Port Reflectometer: an Alternative Network Analyzer for THz Region

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Outline

- General Background of Network Analyzer
- Principles of Six-Port Reflectometer
- WR-15 Six-port Reflectometer
 - Design, Measurement Setup
 - Results as Network Analyzer
 - Results as an Embedded Sensor into other Systems
- Other Potential Applications (beyond network analyzer)



What is Network Analyzer?



not about computer networks





especially to measure reflection and transmission



referred to "electrical" networks used to analyze the properties of



operating frequencies range from 9 kHz to 500 GHz



Why Test Components?

- Verify specifications of "building blocks" for more complex radio-frequency (RF) system
- Ensure distortionless transmission of communications signals



• Ensure good match when absorbing power (e.g. an anteanna)

How Commercial Network Analyzer Works? (Signal Separation)



measure incident signal for reference

separate incident and reflected signals





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 - mismatch between two adjacent stages in a frequency multiplier chain.
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Overview of Six-port Technique

 Engen invented six-port technique in 1977*.



- Six-port technique is a method of network analysis.
- Six-port *reflectometer* (SPR): measure only reflection coefficient.
- Six-port *network analyzer* (SPNA): measure both reflection and transmission.



Network Analysis Methodology Comparison

• Conventional (commercial, four-port) NA: signal separation method



Six-port VNA (reflectometer): signal
 interference method





Commercial VNA



 $\frac{b_3}{b_4} = \frac{A\Gamma + B}{C\Gamma + 1}$

Six-port reflectometer



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Six-Port Theory: Determination of w and Γ



- Intersection of Circles determines ratio b₃/b₄
- "true" Γ related by bilinear transform: requires four-port calibration
- First step of six-port calibration is to get the value of five "network constants:"
 - *1.* w_1 (real)
 - 2. w_2 (complex)
 - 3. ρ (scalar)
 - 4. ζ (scalar)





Quadratic Surface in P-space maps out an ellipse:

$$A\left(\frac{P_{3}}{P_{4}}\right)^{2} + 2B\left(\frac{P_{3}P_{5}}{P_{4}^{2}}\right) + C\left(\frac{P_{5}}{P_{4}}\right)^{2} + 2D\left(\frac{P_{3}}{P_{4}}\right) + 2E\left(\frac{P_{5}}{P_{4}}\right) + F = 0$$

Where,

$$\begin{array}{l} A = a \\ B = \zeta \ (c - a - b)/2 \\ C = \zeta^2 b \\ D = [R^2(b - a - c) + a(a - b - c)]/2 \\ E = \zeta \ [R^2(a - b - c) + b(b - a - c)]/2 \\ F = [R^4 + R^2(c - a - b) + ab] \end{array} \qquad \begin{array}{l} a = |w_1 - R_c|^2 \\ b = |R_c|^2 \\ c = |w_1|^2 \\ c = |w_1|^2 \\ \zeta = 1/|K|^2 \end{array} \qquad \begin{array}{l} \left. \left. \right. \right. \\ \left. \right$$

General Six-Port Calibration Strategy

- Measure Response of Power Detectors to Sliding Load
- Plot Power Ratios Against One-Another → Ellipse in P-plane
- Determine Five Coefficients via Least-Squares Fit,

$$\frac{A}{F}, \frac{B}{F}, \frac{C}{F}, \frac{D}{F}, \frac{E}{F}$$

- Algebraically Determine Six-Port "Network Constants"
- Calibrated Effective Four-Port Using One of Several Standard Methods



Comparing Six-port Reflectometer to Conventional Network Analyzer

• <u>Advantage</u>

Simpler structure; fewer components Less expensive Easily embedded to other systems No need for phase-locked signal sources

<u>Drawbacks</u> (mainly due to broadband nature of signal detection)
 Limited dynamic range, typically limited to 50–60 dB
 Sensitive to spurious signals (e.g. harmonics)



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• WR-15 (V-Band, 50-75 GHz) Six-port Reflectometer

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- Results as an Embedded Sensor into other Systems: measuring mismatch between two adjacent stages in a frequency multiplier chain.
- Other Potential Applications (beyond Network Analyzer)



Block Design





DUT's include

- fixed load, short, sliding shorts, sliding loads: for calibration;
- various WR15 components: as network analyzer;
- frequency multiplier (doubler) D124 B63: as embedded sensor.



Measurement Setup





Initial Data (Standing Wave by Sliding Short) — 67 GHz as an Example





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- Other Potential Applications (beyond Network Analyzer)



Six-Port Calibration Results Compared to Commercial Network Analyzer for Four Couplers









Six-Port Calibration Results Compared to Commercial Network Analyzer for Horn Antenna and Two Low Pass Filters







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WR-15 Six-port Reflectometer

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Why Study a Frequency Multiplier Chain? (THz Gap)





How Output Power Changed by Introducing Six-Port Reflectometer





Γ Magnitude Results at V1=24V





Γ Phase Results at V1=24V





Comparison of $|\Gamma|$ and Output Power at Input Bias of V₁=24 V





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Potential Application I: Near-Field Imaging





Potential Application II: Dielectric Measurements on Fluids





Summary

- Introduced a general background of network analyzer
- Explained principles of Six-Port Reflectometer
- Demonstrated a WR-15 Six-port Reflectometer
 - the results are in great agreement with commercial network analyzer when measuring variant components.
 - used as an embedded sensor into a frequency multiplier chain and measured the mismatch between two adjacent stages
- Proposed other potential applications
 - > THz near-field imaging
 - dielectric measurements on polar liquids



Thank You!



Research Motivation

- In-situ monitoring of the performance and operation of adjacent stages in a frequency multiplier chain.
- Directly measure the impedance mismatch between adjacent stages using an embedded sensing circuit (sixport reflectometer).
- Use it for studying the behavior of multipliers and as a guide for adjusting external operating parameters that impact performance of the entire chain.



Appendix I: How to Get Ellipse Eqs.

 $|w|^{2} = P_{3}/P_{4}$ (2.19) $|w - w_{1}|^{2} = \zeta P_{5}/P_{4}$ (2.20) $|w - w_{2}|^{2} = \rho P_{6}/P_{4}.$ (2.21) expanding left hand sides of (2.20) $\longrightarrow (w - w_{1})(w^{*} - w_{1}^{*}) = \zeta \frac{P_{5}}{P_{4}}$ (2.24) $|w|^{2} - 2 \operatorname{Re}(ww_{1}^{*}) + |w_{1}|^{2} = \zeta \frac{P_{5}}{P_{4}}$ (2.24)

substituting (2.19) into (2.24) and expanding $Re(ww_1^*) \longrightarrow$

$$\frac{P_3}{P_4} - 2[(\operatorname{Re}(w))(\operatorname{Re}(w_1)) + (\operatorname{Im}(w))(\operatorname{Im}(w_1))] + |w_1|^2 = \zeta \frac{P_5}{P_4}$$
(2.25)

perform exactly the same operations on (2.21):

$$|w|^{2} - 2\operatorname{Re}(ww_{2}^{*}) + |w_{2}|^{2} = \rho \frac{P_{6}}{P_{4}}$$
 (2.28)

Appendix I: How to Get Ellipse Eqs. (continued)

substitute (2.19) into (2.28) and expand $Re(ww_2)$

$$\frac{P_3}{P_4} - 2[(\operatorname{Re}(w))(\operatorname{Re}(w_2)) + (\operatorname{Im}(w))(\operatorname{Im}(w_2))] + |w_2|^2 = \rho \frac{P_6}{P_4}$$
(2.29)

(2.25) and (2.29) can be solved to determine Re(w) and Im(w)

$$\operatorname{Re}(w) = \frac{1}{2} \frac{(\operatorname{Im}(w_1))(|w_2|^2 + P_3/P_4 - \rho P_6/P_4) + (\operatorname{Im}(w_2))(\zeta P_5/P_4 - P_3/P_4 - |w_1|^2)}{(\operatorname{Re}(w_2))(\operatorname{Im}(w_1)) - (\operatorname{Re}(w_1))(\operatorname{Im}(w_2))}$$

(2.30)

$$Im(w) = -\frac{1}{2} \frac{(\text{Re}(w_1))(|w_2|^2 + P_3/P_4 - \rho P_6/P_4) + (\text{Re}(w_2))(\zeta P_5/P_4 - P_3/P_4 - |w_1|^2)}{(\text{Re}(w_2))(\text{Im}(w_1)) - (\text{Re}(w_1))(\text{Im}(w_2))}$$

(2.31)

Appendix I: How to Get Ellipse Eqs. (continued 2)

squaring (2.30) and (2.31) and add them together.

$$a\left(\frac{P_{3}}{P_{4}}\right)^{2} + b\zeta^{2}\left(\frac{P_{5}}{P_{4}}\right)^{2} + c\rho^{2}\left(\frac{P_{6}}{P_{4}}\right)^{2} + (c-a-b)\zeta\left(\frac{P_{3}P_{5}}{P_{4}^{2}}\right)$$

$$+(b-a-c)\rho\left(\frac{P_{3}P_{6}}{P_{4}^{2}}\right)+(a-b-c)\zeta\rho\left(\frac{P_{5}P_{6}}{P_{4}^{2}}\right)+a(a-b-c)\frac{P_{3}}{P_{4}}$$

$$+b(b-a-c)\zeta \frac{P_{5}}{P_{4}}+c(c-a-b)\rho \frac{P_{6}}{P_{4}}+abc=0$$



First Step of Six-Port Calibration (Engen's Sliding Termination Method)

Constraining Relation between $|b_3|, |b_4|, |b_5|$, and $|b_6|$:

$$a\left(\frac{P_{3}}{P_{4}}\right)^{2} + b\zeta^{2}\left(\frac{P_{5}}{P_{4}}\right)^{2} + c\rho^{2}\left(\frac{P_{6}}{P_{4}}\right)^{2} + (c - a - b)\zeta\left(\frac{P_{3}P_{5}}{P_{4}^{2}}\right) + (b - a - c)\rho\left(\frac{P_{3}P_{6}}{P_{4}^{2}}\right)$$
$$+ (a - b - c)\zeta\rho\left(\frac{P_{5}P_{6}}{P_{4}^{2}}\right) + a(a - b - c)\frac{P_{3}}{P_{4}} + b(b - a - c)\zeta\frac{P_{5}}{P_{4}}$$
$$+ c(c - a - b)\rho\frac{P_{6}}{P_{4}} + abc = 0$$

Where,

$$a = |w_1 - w_2|^2$$
 $b = |w_2|^2$ $c = |w_1|^2$

First Step of Six-Port Calibration — continued

Constrain Γ to lie on a circle (i.e., sliding termination) \longrightarrow maps into circle in w-plane

$$|w - R_c|^2 = R^2$$
 and recall $|w - w_2|^2 = \rho \frac{P_6}{P_4}$

Quadratic Surface in P-space maps out an ellipse:

$$A\left(\frac{P_{3}}{P_{4}}\right)^{2} + 2 B\left(\frac{P_{3}P_{5}}{P_{4}^{2}}\right) + C\left(\frac{P_{5}}{P_{4}}\right)^{2} + 2 D\left(\frac{P_{3}}{P_{4}}\right) + 2 E\left(\frac{P_{5}}{P_{4}}\right) + F = 0$$
Where,

$$A = a$$

$$B = \zeta (c - a - b)/2$$

$$C = \zeta^{2}b$$

$$D = [R^{2}(b - a - c) + a(a - b - c)]/2$$

$$E = \zeta [R^{2}(a - b - c) + b(b - a - c)]/2$$

$$C = [W_{1}]^{2}$$

$$\int_{3/1}^{2} \frac{\sqrt{2}}{12} \int_{2}^{2} \frac{\sqrt{2}}{12} \int_{$$



Appendix II: More Examples of Calibration Standard Results







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.0,

15

kl-27, kkl-27, ks, kks

Sling positions

20

25

,23,



Basic Probe Simulation Model



- Waveguide size: 148*74 (WR15, 50~75GHz)
- Channel size: 20*13
- Channel distance: 40
- Microstrip width: 6
- MLine characteristic impedance Z_0 : 50.48 Ohm
- Substrate width:19
- Substrate thickness:3



